Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination
10/682,349	ZAUDTKE ET AL.
Examiner	Art Unit
Christopher B. Shin	2182

SEARCHED					
Class	Subclass	Date	Examiner		
235	462.15	6/15/2005	CBS .		
235	472.01	6/15/2005	CBS		
341	176	6/15/2005	CBS		
707	10,102	6/15/2005	CBS		
707	201	6/15/2005	CBS		
713	1-2, 100	6/15/2005	CBS		
713	300-340	6/15/2005	CBS		
710	1-5, 8	6/15/2005	CBS		
710	14	6/15/2005	CBS		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
713	2,300	6/15/2005	CBS	
710	10	6/15/2005	CBS	
275	462.15	6/15/2005	CBS	
472	2.01	6/15/2005	CBS	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
PALM FOR DOUBLE PATENTING	6/15/2005	CBS		
PLUS	6/15/2005	CBS		
EAST (USPGPUB, USPAT, USOCR EPO, JPO, DERWENT, IBM_TDB)	6/15/2005	CBS		